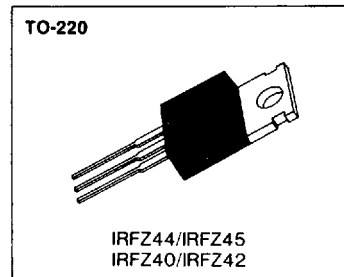


FEATURES

- Lower $R_{DS(on)}$
- Improved inductive ruggedness
- Fast switching times
- Rugged polysilicon gate cell structure
- Lower input capacitance
- Extended safe operating area
- Improved high temperature reliability



PRODUCT SUMMARY

| Part Number | V_{DS} | $R_{DS(on)}$ | I_D |
|-------------|----------|----------------|-------|
| IRFZ44 | 60V | 0.028 Ω | 35A |
| IRFZ45 | 60V | 0.035 Ω | 35A |
| IRFZ40 | 50V | 0.028 Ω | 35A |
| IRFZ42 | 50V | 0.035 Ω | 35A |

* Current limited by wire & pin diameter

MAXIMUM RATINGS

| Characteristic | Symbol | IRFZ44 | IRFZ45 | IRFZ40 | IRFZ42 | Unit |
|---|----------------|---------------------|--------|--------|--------|------------------------|
| Drain-Source Voltage (1) | V_{DSS} | 60 | | 50 | | Vdc |
| Drain-Gate Voltage ($R_{GS}=1.0M\Omega$)(1) | V_{DGR} | 60 | | 50 | | Vdc |
| Gate-Source Voltage | V_{GS} | ± 20 | | | | Vdc |
| Continuous Drain Current $T_C=25^\circ C$ | I_D | 35 | 35 | 35 | 35 | Adc |
| Continuous Drain Current $T_C=100^\circ C$ | I_D | 35 | 33 | 35 | 33 | Adc |
| Drain Current—Pulsed (3) | I_{DM} | 210 | 190 | 210 | 190 | Adc |
| Gate Current—Pulsed | I_{GM} | ± 1.5 | | | | Adc |
| Single Pulsed Avalanche Energy (4) | E_{AS} | 53 | | | | mJ |
| Avalanche Current | I_{AS} | 35 | | | | A |
| Total Power Dissipation at $T_C=25^\circ C$ Purposes, above $25^\circ C$ | P_D | 150 1.2 | | | | Watts W/ $^\circ C$ |
| Operating and Storage Junction Temperature Range | T_J, T_{stg} | -55 to 175 $^\circ$ | | | | $^\circ C$ |
| Maximum Lead Temp. for Soldering Purposes, 1/8" from case for 5 seconds | T_L | 300 | | | | $^\circ C$ |

- Notes:** (1) $T_J=25^\circ C$ to $175^\circ C$
 (2) Pulse test. Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$
 (3) Repetitive rating: Pulse with limited by max junction temperature
 (4) $L=50\mu H$, $V_{dd}=25V$, $R_G=25\Omega$, Starting $T_J=25^\circ C$

ELECTRICAL CHARACTERISTICS ($T_C=25^\circ\text{C}$ unless otherwise specified)

| Symbol | Characteristic | Min | Typ | Max | Units | Test Conditions |
|--------------|---|-----|------|-------|------------|---|
| BV_{DSS} | Drain-Source Breakdown Voltage | | | | | $V_{GS}=0V, I_D=250\mu A$ |
| | IRFZ44/45 | 60 | — | — | V | |
| | IRFZ40/42 | 50 | — | — | | |
| $V_{GS(th)}$ | Gate Threshold Voltage | 2.0 | — | 4.0 | V | $V_{DS}=V_{GS}, I_D=250\mu A$ |
| I_{GSS} | Gate-Source Leakage Forward | — | — | 100 | nA | $V_{GS}=20V$ |
| I_{GSS} | Gate-Source Leakage Reverse | — | — | -100 | nA | $V_{GS}=-20V$ |
| I_{DSS} | Zero Gate Voltage Drain Current | — | — | 250 | μA | $V_{DS}=\text{Max. Rating}, V_{GS}=0V$ $V_{DS}=0.8\text{Max. Rating}, V_{GS}=0V, T_C=150^\circ\text{C}$ |
| | | — | — | 1000 | μA | |
| $I_{D(on)}$ | On-State Drain-Source Current (2) | 35 | — | — | A | $V_{DS}\geq 1.2V, V_{GS}=10V$ |
| $R_{DS(on)}$ | Static Drain-Source | — | — | 0.028 | Ω | $V_{GS}=10V, I_D=33A$ |
| | On-State Resistance | | | 0.035 | | |
| g_{fs} | Forward Transconductance (2) | 15 | — | — | U | $V_{DS}\geq 50V, I_D=33A$ |
| C_{iss} | Input Capacitance | — | 2450 | — | pF | $V_{GS}=0V$ |
| C_{oss} | Output Capacitance | — | 740 | — | pF | $V_{DS}=25V$ |
| C_{rss} | Reverse Transfer Capacitance | — | 360 | — | pF | $f=1.0\text{MHz}$ |
| $t_{d(on)}$ | Turn-On Delay Time | — | — | 32 | ns | $V_{DD}=0.5 BV_{DSS}, I_D=52A, Z_\theta=9.1\Omega$ (MOSFET switching times are essentially independent of operating temperature) |
| t_r | Rise Time | — | — | 210 | ns | |
| $t_{d(off)}$ | Turn-Off Delay Time | — | — | 75 | ns | |
| t_f | Fall Time | — | — | 130 | ns | |
| Q_g | Total Gate Charge (Gate-Source Pulse Gate-Drain) | — | — | 100 | nC | $V_{GS}=10V, I_D=52A, V_{DS}=0.8\text{Max. Rating}$ (Gate charge is essentially independent of operating temperature) |
| Q_{gs} | Gate-Source Charge | — | — | 21 | nC | |
| Q_{gd} | Gate-Drain ("Miller") Charge | — | — | 58 | nC | |

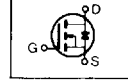
THERMAL RESISTANCE

| | | | | | |
|------------|---------------------|-----|-----|-----|---|
| R_{thJC} | Junction-to-Case | MAX | 1.0 | K/W | |
| R_{thCS} | Case-to-Sink | TYP | 0.5 | K/W | Mounting surface flat smooth, and greased |
| R_{thJA} | Junction-to-Ambient | MAX | 80 | K/W | Free Air Operation |

- Notes:** (1) $T_J=25^\circ\text{C}$ to 175°C
 (2) Pulse test Pulse width $\leq 300\mu s$, Duty Cycle $\leq 2\%$
 (3) Repetitive rating Pulse width limited by max junction temperature

SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS

| Symbol | Characteristic | | Min | Typ | Max | Units | Test Conditions |
|-----------------|--|-----------|-----|-----|-----|-------|--|
| I _S | Continuous Source Current (Body Diode) | IRFZ44/40 | — | — | 35 | A | Modified MOSFET integral reverse P-N junction rectifier |
| | | IRFZ45/42 | — | — | 35 | A | |
| I _{SM} | Pulse-Source Current (3) | IRFZ44/40 | — | — | 210 | A | |
| | | IRFZ45/42 | — | — | 190 | A | |
| V _{SD} | Diode Forward Voltage All | | — | — | 2.5 | V | T _C =25°C, I _S =35A, V _{GS} =0V |
| t _{rr} | Reverse Recovery Time | | — | — | 250 | nS | T _J =25°C, I _F =35A, dI _F /dt=100A/μS |



- Notes:** (1) T_J=25°C to 175°C
 (2) Pulse test Pulse width≤300μs, Duty Cycle≤2%
 (3) Repetitive rating Pulse with limited by max junction temperature

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